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1	Application/Control No.
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10560964

Examiner

David M Brunsman

Applicant(s)/Patent Under Reexamination

YOON ET AL.

Art Unit

1793

ORIGINAL						1	INTERNATIONAL CLASSIFICATION												
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☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47																			
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NONE	Total Claims Allowed:					
(Assistant Examiner)	(Date)	23				
/David M Brunsman/ Primary Examiner.Art Unit 1793	11-24-2008	O.G. Print Claim(s)	O.G. Print Figure			
(Primary Examiner)	(Date)	1,21	none			